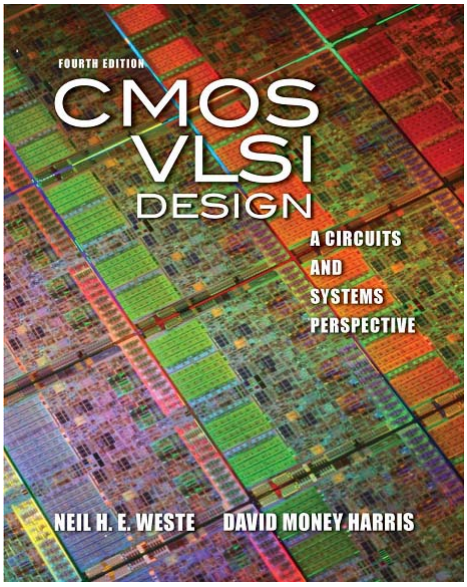


Lecture 1: Circuits & Layout

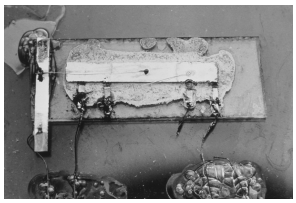
Prof. Ioannis Savidis

Outline

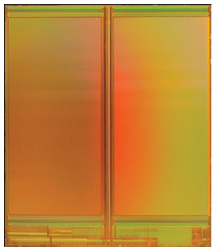
- A Brief History
- CMOS Gate Design
- Pass Transistors
- CMOS Latches & Flip-Flops
- Standard Cell Layouts
- Stick Diagrams

A Brief History

- 1958: First integrated circuit
  - Flip-flop using two transistors
  - Built by Jack Kilby at Texas Instruments
- 2010
  - Intel Core i7 μprocessor
    - 2.3 billion transistors
  - 64 Gb Flash memory
    - > 16 billion transistors



Courtesy Texas Instruments



[Trinh09]

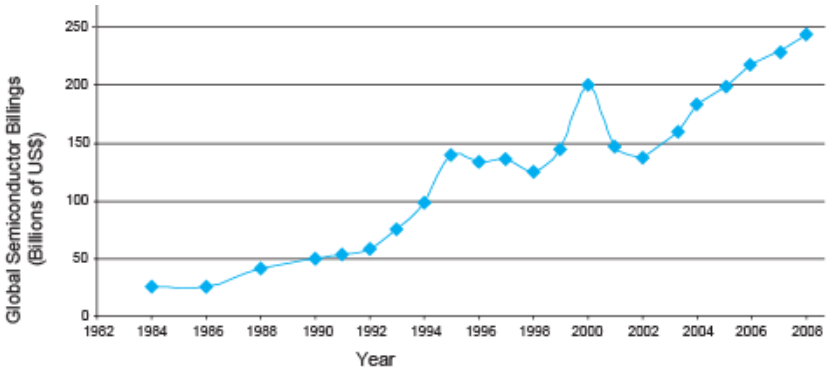
Growth Rate

- 53% compound annual growth rate over 50 years
  - No other technology has grown so fast so long
- Driven by miniaturization of transistors
  - Smaller is cheaper, faster, lower in power!
  - Revolutionary effects on society

[Moore65]
Electronics Magazine

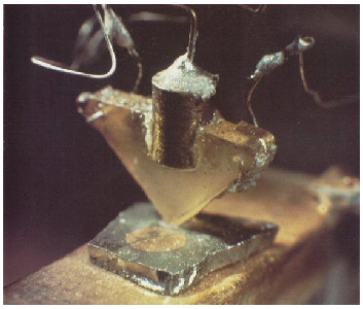
Annual Sales

- >10^{19} transistors manufactured in 2008
  - 1 billion for every human on the planet



Invention of the Transistor

- Vacuum tubes ruled in first half of 20th century
  Large, expensive, power-hungry, unreliable
- 1947: first point contact transistor
  - John Bardeen and Walter Brattain at Bell Labs
  - See *Crystal Fire*
    by Riordan, Hoddeson



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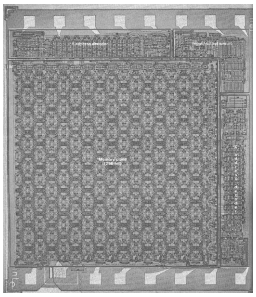
Transistor Types

- Bipolar transistors
  - npn or pnp silicon structure
  - Small current into very thin base layer controls large currents between emitter and collector
  - Base currents limit integration density
- Metal Oxide Semiconductor Field Effect Transistors
  - nMOS and pMOS MOSFETS
  - Voltage applied to insulated gate controls current between source and drain
  - Low power allows very high integration

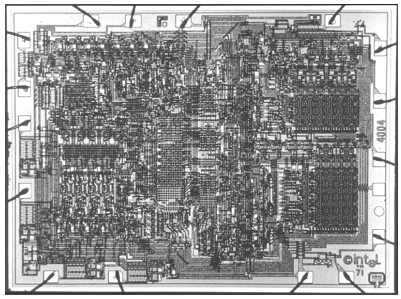
MOS Integrated Circuits

- 1970's processes usually had only nMOS transistors
  - Inexpensive, but consume power while idle



[Vadasz69]
© 1969 IEEE.

Intel 1101 256-bit SRAM



Intel Museum.
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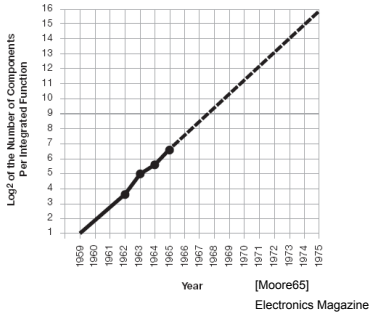
Intel 4004 4-bit μProc

- 1980s-present: CMOS processes for low idle power

Moore's Law: Then

- 1965: Gordon Moore plotted transistor on each chip
  - Fit straight line on semilog scale
  - Transistor counts have doubled every 26 months



[Moore65]
Electronics Magazine

Integration Levels

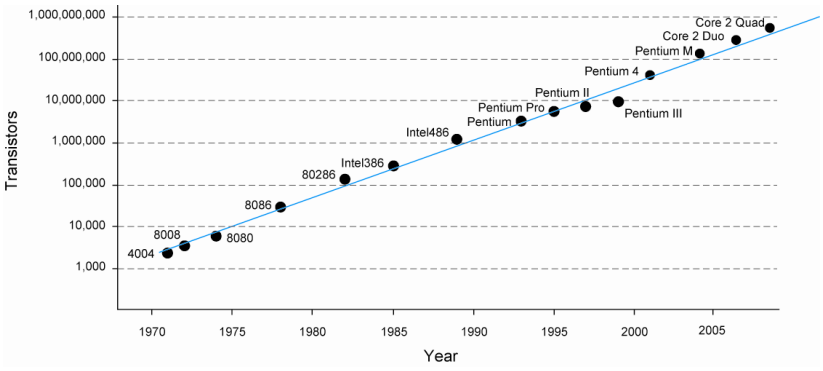
SSI: 10 gates

MSI: 1000 gates

LSI: 10,000 gates

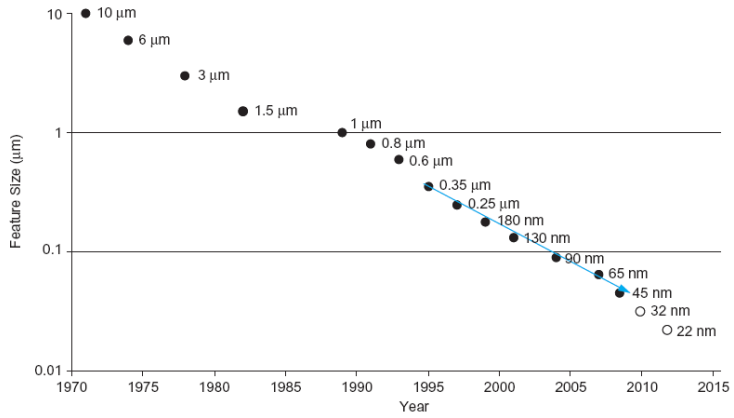
VLSI: > 10k gates

And Now…



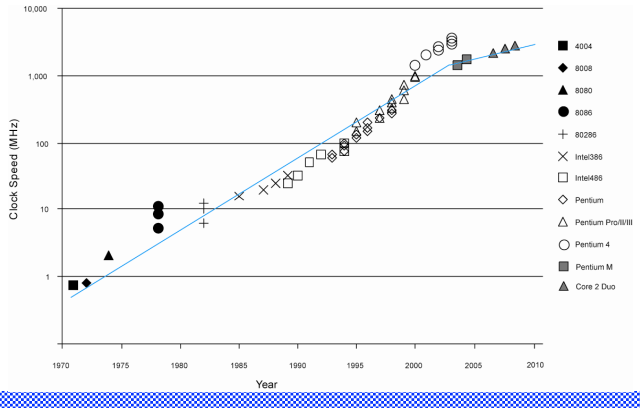
Feature Size

- Minimum feature size shrinking 30% every 2-3 years



Corollaries

- Many other factors grow exponentially
  - Ex: clock frequency, processor performance

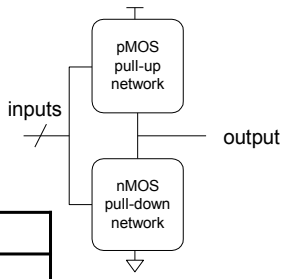


CMOS Gate Design

- Activity:
  - Sketch a 4-input CMOS NOR gate

Complementary CMOS

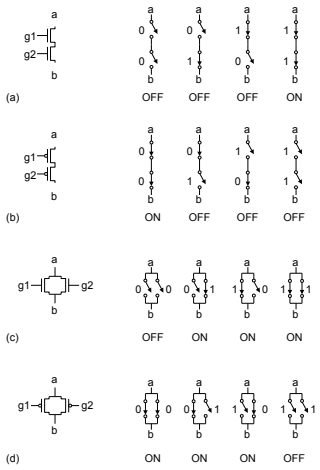
- Complementary CMOS logic gates
  - nMOS *pull-down network*
  - pMOS *pull-up network*
  - a.k.a. static CMOS



	Pull-up OFF	Pull-up ON
Pull-down OFF	Z (float)	1
Pull-down ON	0	X (crowbar)

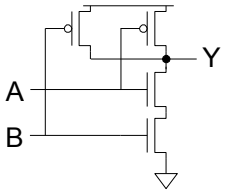
Series and Parallel

- nMOS: 1 = ON
- pMOS: 0 = ON
- *Series*: both must be ON
- *Parallel*: either can be ON



Conduction Complement

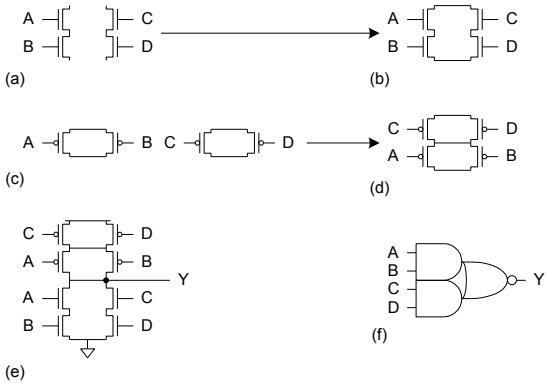
- Complementary CMOS gates always produce 0 or 1
- Ex: NAND gate
  - Series nMOS: Y=0 when both inputs are 1
  - Thus Y=1 when either input is 0
  - Requires parallel pMOS



- Rule of *Conduction Complements*
  - Pull-up network is complement of pull-down
  - Parallel -> series, series -> parallel

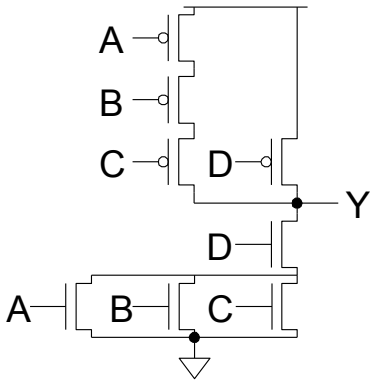
Compound Gates

- *Compound gates* can do any inverting function
- Ex: $Y = \overline{A \bullet B + C \bullet D}$ (AND-AND-OR-INVERT, AOI22)



Example: O3AI

- $Y = \overline{(A + B + C) \bullet D}$

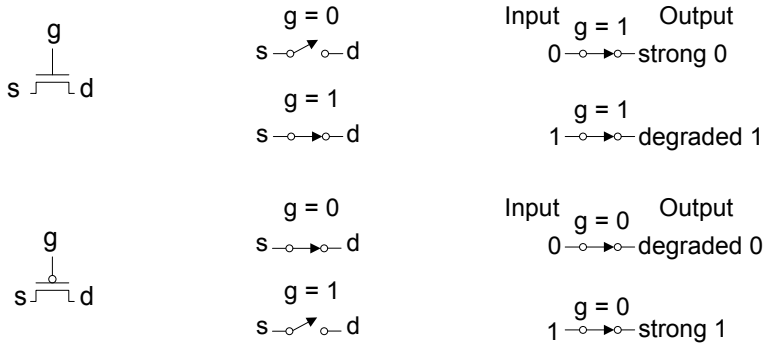


Signal Strength

- *Strength* of signal
  - How close it approximates ideal voltage source
- V_{DD} and GND rails are strongest 1 and 0
- nMOS pass strong 0
  - But degraded or weak 1
- pMOS pass strong 1
  - But degraded or weak 0
- Thus nMOS are best for pull-down network

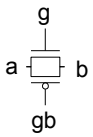
Pass Transistors

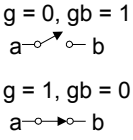
- Transistors can be used as switches

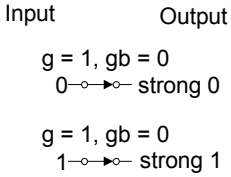


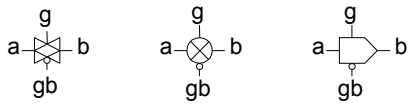
Transmission Gates

- Pass transistors produce degraded outputs
- *Transmission gates* pass both 0 and 1 well





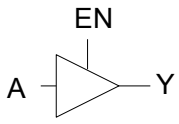


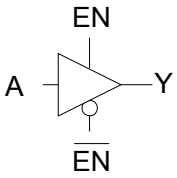


Tristates

- *Tristate buffer* produces Z when not enabled

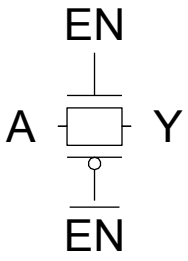
EN	A	Y
0	0	
0	1	
1	0	
1	1	





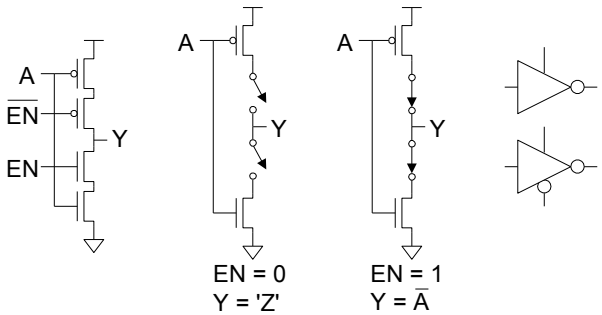
Nonrestoring Tristate

- Transmission gate acts as tristate buffer
  - Only two transistors
  - But *nonrestoring*
    - Noise on A is passed on to Y



Tristate Inverter

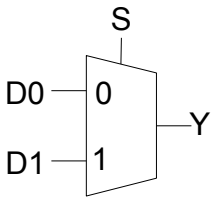
- Tristate inverter produces restored output
  - Violates conduction complement rule
  - Because we want a Z output



Multiplexers

- 2:1 multiplexer chooses between two inputs

S	D1	D0	Y
0	X	0	
0	X	1	
1	0	X	
1	1	X	

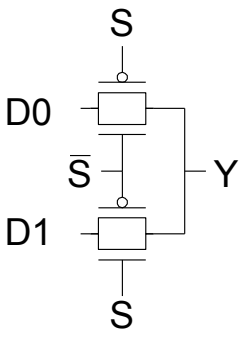


Gate-Level Mux Design

- $Y = SD_1 + \overline{S}D_0$ (too many transistors)
- How many transistors are needed?

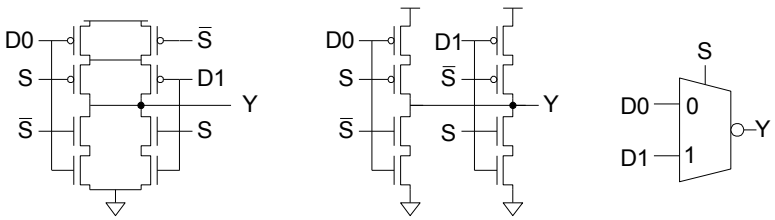
Transmission Gate Mux

- Nonrestoring mux uses two transmission gates
  - Only 4 transistors



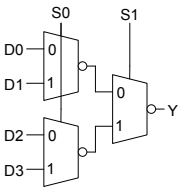
Inverting Mux

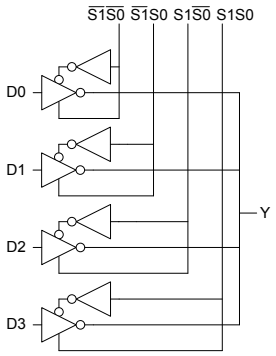
- Inverting multiplexer
  - Use compound AOI22
  - Or pair of tristate inverters
  - Essentially the same thing
- Noninverting multiplexer adds an inverter



4:1 Multiplexer

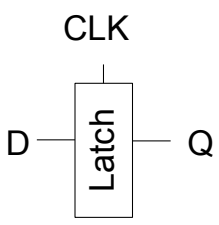
- 4:1 mux chooses one of 4 inputs using two selects
  - Two levels of 2:1 muxes
  - Or four tristates

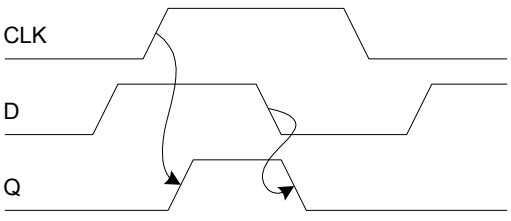




D Latch

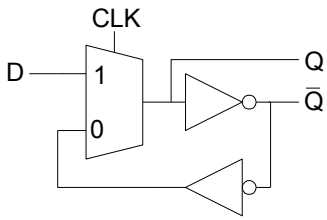
- When CLK = 1, latch is *transparent*
  - D flows through to Q like a buffer
- When CLK = 0, the latch is *opaque*
  - Q holds its old value independent of D
- a.k.a. *transparent latch* or *level-sensitive latch*

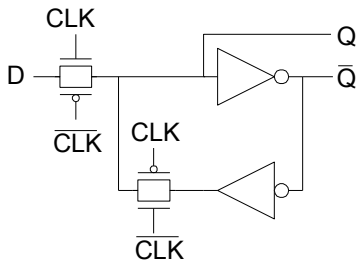




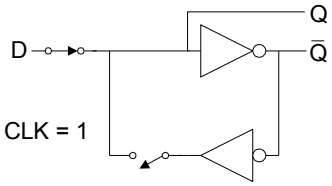
D Latch Design

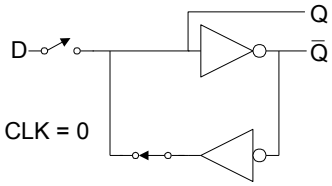
- Multiplexer chooses D or old Q

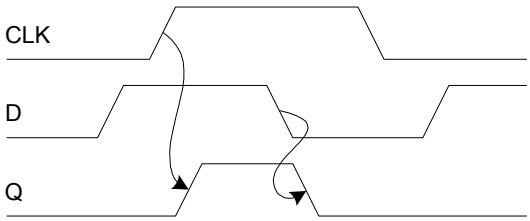




D Latch Operation

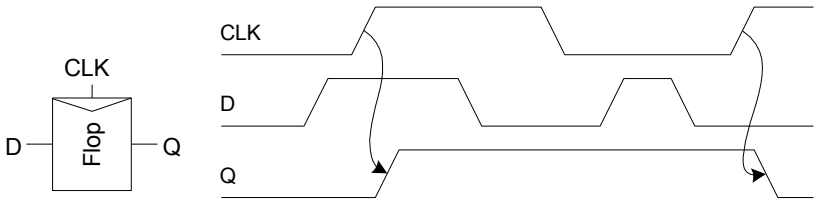






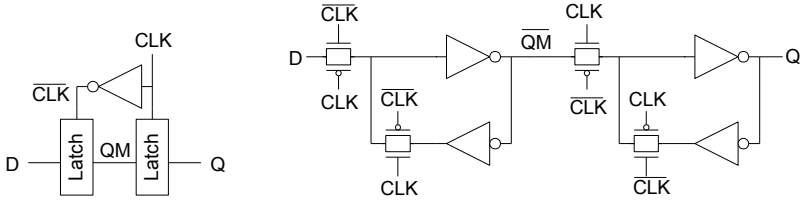
D Flip-flop

- When CLK rises, D is copied to Q
- At all other times, Q holds its value
- a.k.a. *positive edge-triggered flip-flop*, *master-slave flip-flop*

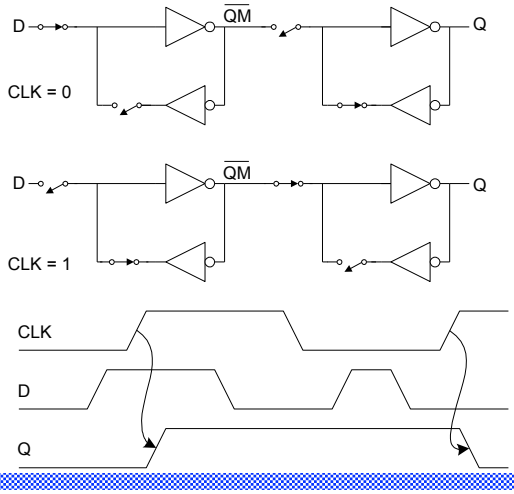


D Flip-flop Design

- Built from master and slave D latches

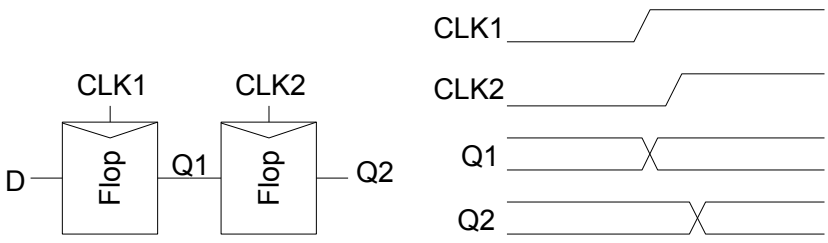


D Flip-flop Operation



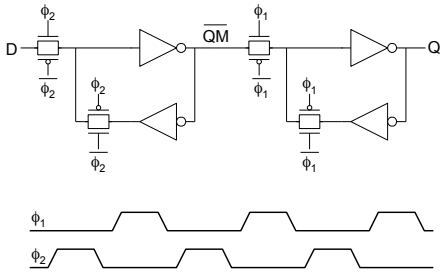
Race Condition

- Back-to-back flops can malfunction from clock skew
  - Second flip-flop fires late
  - Sees first flip-flop change and captures its result
  - Called *hold-time failure* or *race condition*



Nonoverlapping Clocks

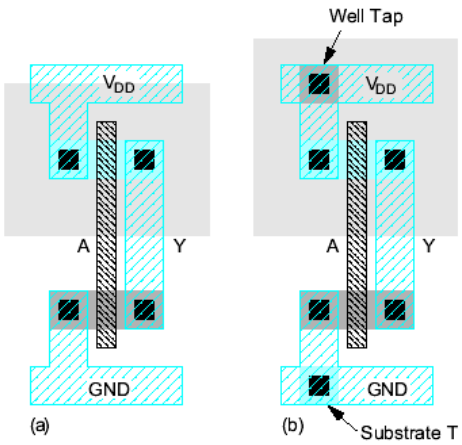
- Nonoverlapping clocks can prevent races
  - As long as nonoverlap exceeds clock skew
- We will use them in this class for safe design
  - Industry manages skew more carefully instead



Gate Layout

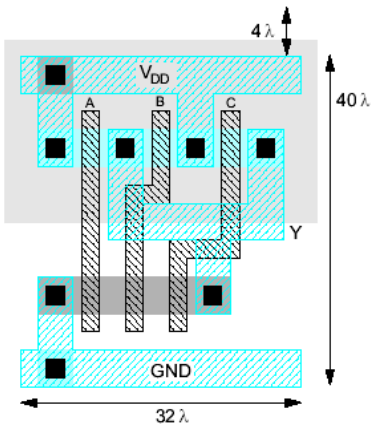
- Layout can be very time consuming
  - Design gates to fit together nicely
  - Build a library of standard cells
- Standard cell design methodology
  - V_{DD} and GND should abut (standard height)
  - Adjacent gates should satisfy design rules
  - nMOS at bottom and pMOS at top
  - All gates include well and substrate contacts

Example: Inverter



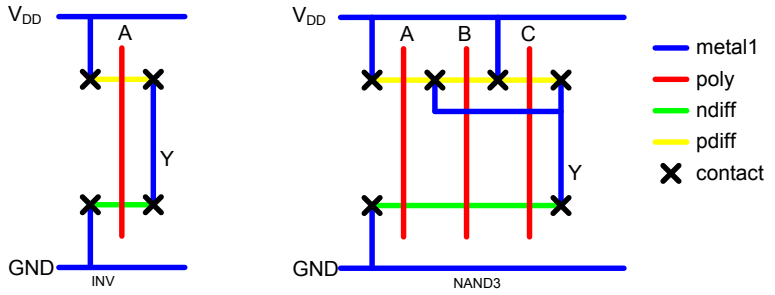
Example: NAND3

- Horizontal N-diffusion and p-diffusion strips
- Vertical polysilicon gates
- Metal1 V_{DD} rail at top
- Metal1 GND rail at bottom
- 32 λ by 40 λ



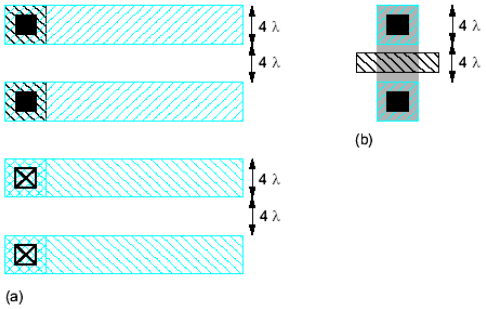
Stick Diagrams

- *Stick diagrams* help plan layout quickly
  - Need not be to scale
  - Draw with color pencils or dry-erase markers



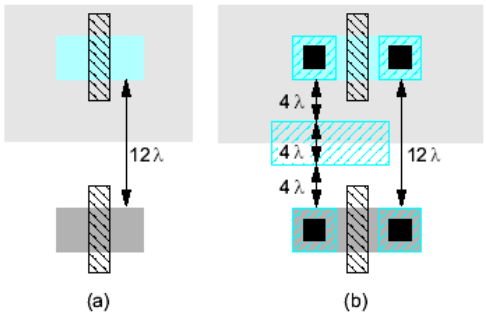
Wiring Tracks

- A *wiring track* is the space required for a wire
  - 4 λ width, 4 λ spacing from neighbor = 8 λ pitch
- Transistors also consume one wiring track



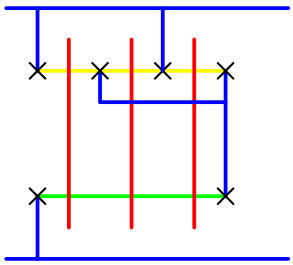
Well spacing

- Wells must surround transistors by 6 λ
  - Implies 12 λ between opposite transistor flavors
  - Leaves room for one wire track



Area Estimation

- Estimate area by counting wiring tracks
  - Multiply by 8 to express in λ



Example: O3AI

- Sketch a stick diagram for O3AI and estimate area
  - $Y = \overline{(A + B + C)gD}$